Applicant(s)/Patent Under Application/Control No. Reexamination 10/005,083 SCHWANDNER, FRANK Notice of References Cited Examiner Art Unit Page 1 of 1 Ahshik Kim 2876 **U.S. PATENT DOCUMENTS** Document Number Date Classification Name Country Code-Number-Kind Code MM-YYYY 03-2000 Rensel, John D. 267/64.11 Α US-6,036,179 US-В US-С D US-US-Ε US-F G US-US-Н US-1 US-J US-Κ US-М US-**FOREIGN PATENT DOCUMENTS Document Number** Date Country Name Classification Country Code-Number-Kind Code MM-YYYY Ν 0 Ρ Q R S Т **NON-PATENT DOCUMENTS** Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages) U W

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